

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/604,174	JENKINS ET AL.	
ſ	Examiner	Art Unit	
	Sun J. Lin	2825	

SEARCHED						
Class	Subclass	Date	Examiner			
716	13	5/25/2005	JSL			
716	12	5/25/2005	JSL			
716	14	5/25/2005	JSL			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
716	13	5/25/2005	JSL			
716	12	5/25/2005	JSL			
716	14	5/25/2005	JSL			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST [USPAT;US-PGPUB]	5/25/2005	JSL			
EAST [UPO;JPO;DERWENT;IBM_TDB=	5/25/2005	JSL			
IEEE	5/25/2005	JSL			
GOOGLE	5/25/2005	JSL			
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